

# Test Report

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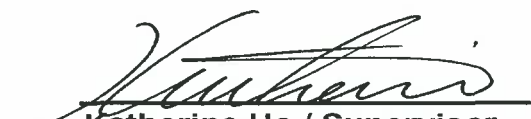
RALEC ELECTRONIC CORPORATION  
 NO.1, CENTRAL 2ND., STREET, NANTZE, EXPORT PROCESSING ZONE,  
 KAOHSIUNG, TAIWAN



The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description : LEAD FREE CHIP RESISTORS ARRAY PRODUCT  
 Style/Item No. : RTA03-4D(0603-8P4R)RTA03-4DJ101  
 Color : SILVER+BLACK  
 Sample Receiving Date : 2007/07/09  
 Testing Period : 2007/07/09 TO 2007/7/16

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**Test Requested** : In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.  
**Test Method** : (1) With reference to US EPA Method 3050B for Lead Content. Analysis was performed by ICP-AES.  
**Test Result(s)** : Please refer to next page(s).

  
**Katherine Ho / Supervisor**  
**Signed for and on behalf of**  
**SGS Taiwan Limited**

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